

N-Channel Enhancement Mode MOSFET

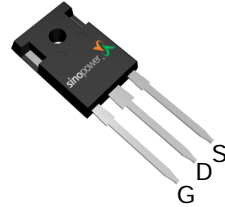
Features

- 650V/20A,
 $R_{DS(ON)} = 0.195\Omega(\text{max.}) @ V_{GS} = 10V$
 $V_{DS} @ T_j, \text{max} = 750V (\text{typ.})$
- Reliable and Rugged
- Avalanche Rated
- Lead Free and Green Devices Available (RoHS Compliant)

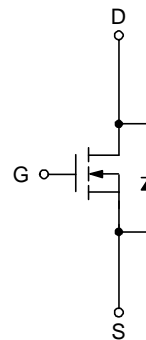
Applications

- AC/DC Power Conversion in Switched Mode Power Supplies (SMPS).
- Uninterruptible Power Supply (UPS),
- Adapter.

Pin Description




Top View of TO-247



N-Channel MOSFET

Ordering and Marking Information

<p>SM6F01NS □□-□□□</p> <div style="margin-left: 20px;"> <p>└─ Assembly Material</p> <p>└─ Handling Code</p> <p>└─ Temperature Range</p> <p>└─ Package Code</p> </div>	<p>Package Code W : TO-247</p> <p>Operating Junction Temperature Range C : -55 to 150 °C</p> <p>Handling Code TU : Tube (30ea/tube)</p> <p>Assembly Material G : Halogen and Lead Free Device</p>
<p>SM6F01NS W :</p> <div style="border: 1px solid black; padding: 2px; display: inline-block; margin-left: 10px;">  <p>SM6F01N XXXXX</p> </div>	<p>XXXXX - Date Code</p>

Note: SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
Common Ratings ($T_A=25^\circ\text{C}$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	650	V
V_{GSS}	Gate-Source Voltage	± 30	
T_J	Maximum Junction Temperature	150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	
I_S	Diode Continuous Forward Current	20 ^a	A
I_{DP}	300 μs Pulse Drain Current Tested	$T_C=25^\circ\text{C}$ 60 ^a	
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$ 20 ^a	
		$T_C=100^\circ\text{C}$ 13 ^a	
P_D	Maximum Power Dissipation for	$T_C=25^\circ\text{C}$ 227	W
		$T_C=100^\circ\text{C}$ 91	
$R_{\theta JC}$	Thermal Resistance-Junction to Case for	0.55	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62.5	
Drain-Source Avalanche Ratings			
dv/dt^b	MOSFET dv/dt ruggedness	50	V/ns
E_{AS}^c	Avalanche Energy, Single Pulsed	490	mJ
I_{AR}^d	Avalanche Current	3.5	A
E_{AR}^d	Repetitive Avalanche Energy	1.2	mJ

Note a : limited by maximum junction temperature.

Note b : $V_{DS}=520\text{V}$, $I_D=20\text{A}$.

Note c : $I_D=3.5\text{A}$, $V_{DD}=50\text{V}$, $T_j=25^\circ\text{C}$.

Note d : Repetitive Rating : Pulse width limited by maximum junction temperature.

Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

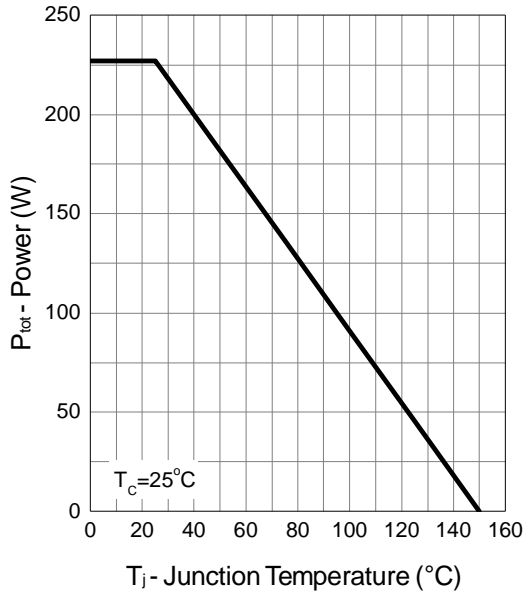
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu A$	650	-	-	V
		$T_J=150^\circ\text{C}$	-	750	-	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=520V, V_{GS}=0V$	-	-	1	μA
		$T_J=150^\circ\text{C}$	-	-	200	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	2.5	3.5	4.5	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	± 100	nA
$R_{DS(ON)}^e$	Drain-Source On-state Resistance	$V_{GS}=10V, I_{DS}=10A$	-	0.17	0.195	Ω
Diode Characteristics						
V_{SD}^e	Diode Forward Voltage	$I_{SD}=20A, V_{GS}=0V$	-	0.9	1.3	V
t_{rr}	Reverse Recovery Time	$I_{SD}=20A, V_R=390V$ $di_{SD}/dt=100A/\mu s$	-	427	-	ns
Q_{rr}	Reverse Recovery Charge		-	8.8	-	μC
I_{rm}	Peak Reverse Recovery Current		-	42	-	A
Dynamic Characteristics^f						
R_G	Gate Resistance	$V_{GS}=0V, V_{DS}=0V,$ $F=1\text{MHz}$	-	1.5	-	Ω
C_{iss}	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=25V,$ Frequency=1.0MHz	-	2120	2750	pF
C_{oss}	Output Capacitance		-	1225	-	
C_{riss}	Reverse Transfer Capacitance		-	43	-	
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=400V, R_L=20\Omega,$ $I_{DS}=20A, V_{GEN}=10V,$ $R_G=6\Omega$	-	16.8	-	ns
T_r	Turn-on Rise Time		-	34	-	
$t_{d(OFF)}$	Turn-off Delay Time		-	55	-	
T_f	Turn-off Fall Time		-	23	-	
Gate Charge Characteristics^f						
Q_g	Total Gate Charge	$V_{DS}=520V, V_{GS}=10V,$ $I_{DS}=20A$	-	63.5	86	nC
Q_{gs}	Gate-Source Charge		-	13.4	-	
Q_{gd}	Gate-Drain Charge		-	31	-	

Note e : Pulse test ; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

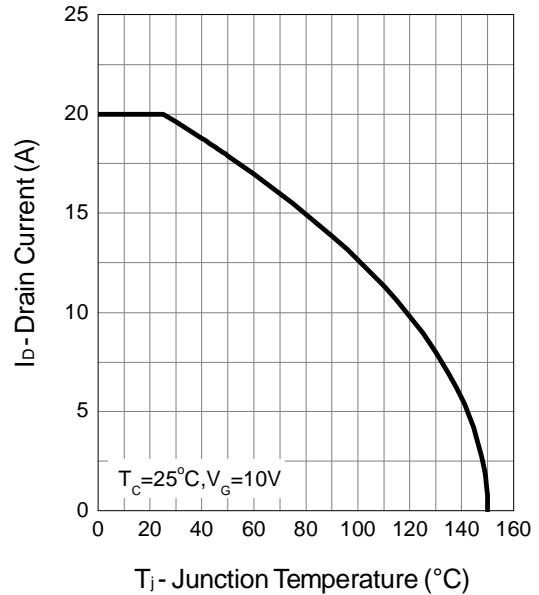
Note f : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

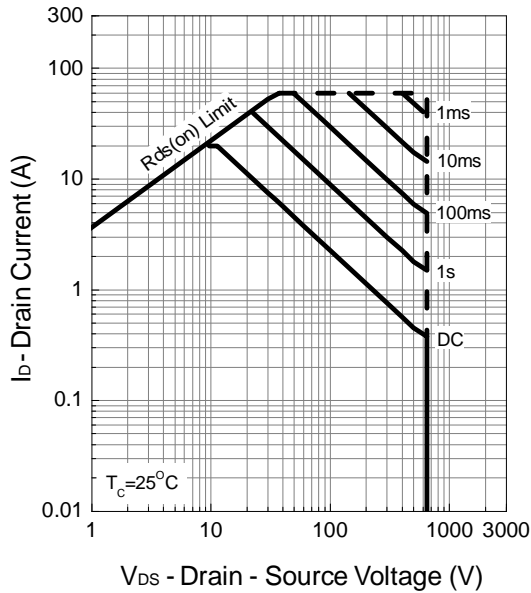
Power Dissipation



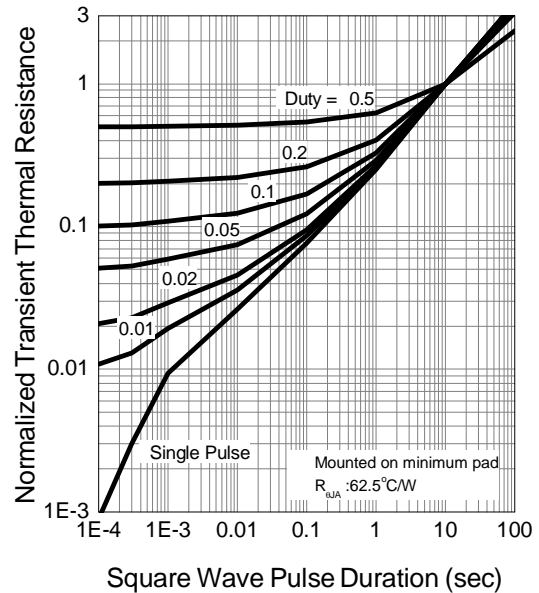
Drain Current



Safe Operation Area

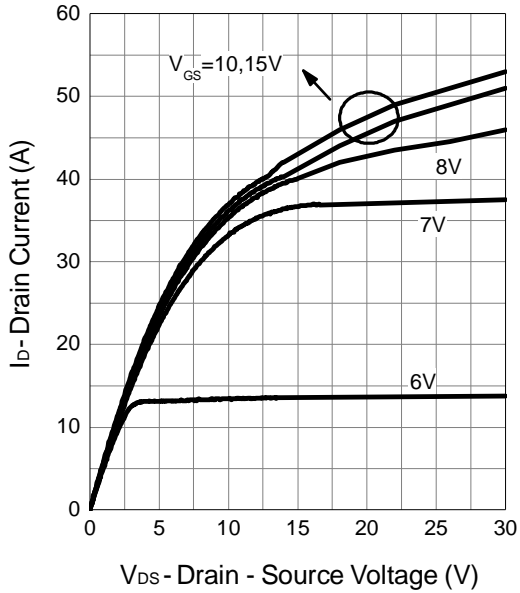


Thermal Transient Impedance

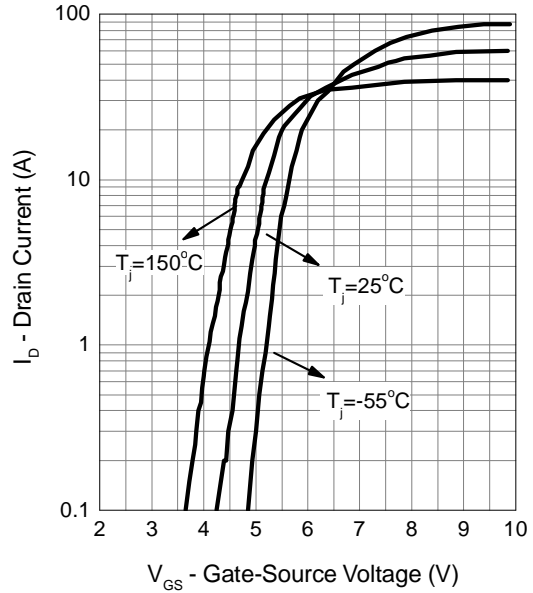


Typical Operating Characteristics (Cont.)

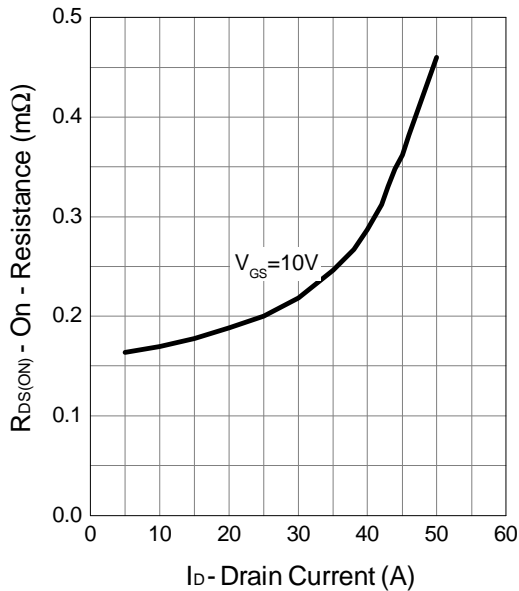
Output Characteristics



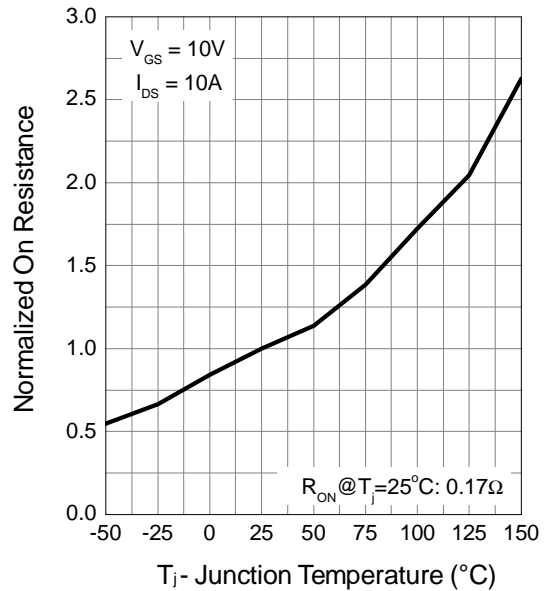
Transfer Characteristics



Drain-Source On Resistance

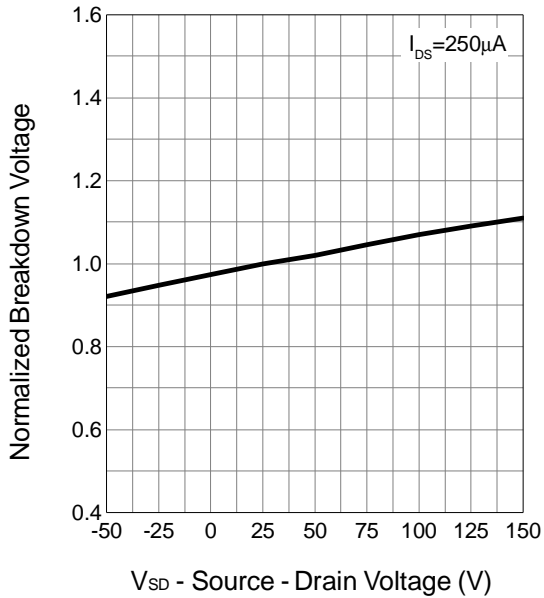


Drain-Source On Resistance

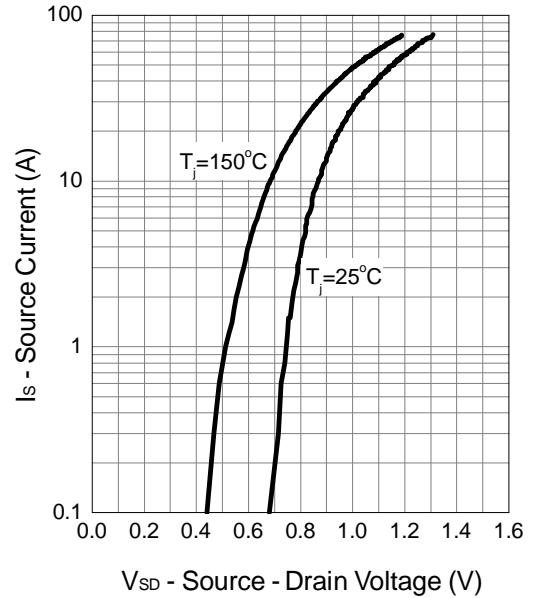


Typical Operating Characteristics (Cont.)

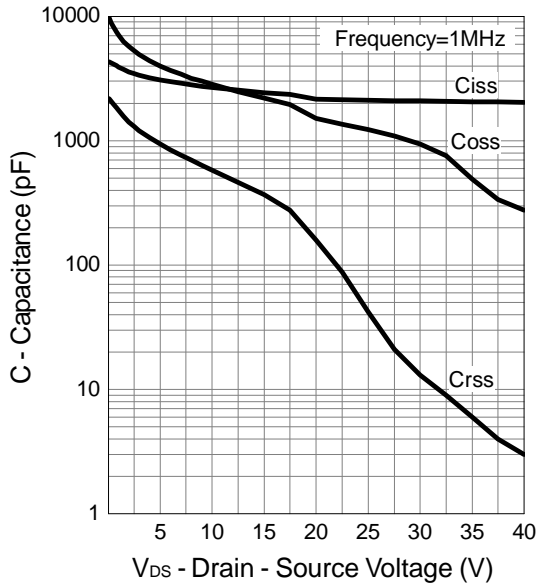
BVDSS vs Junction Temperature



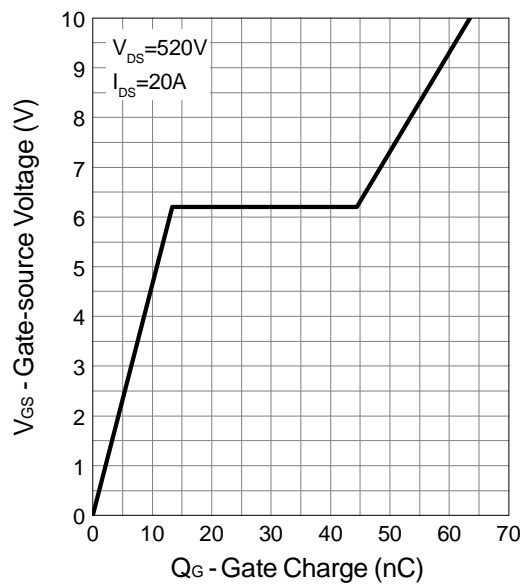
Source-Drain Diode Forward



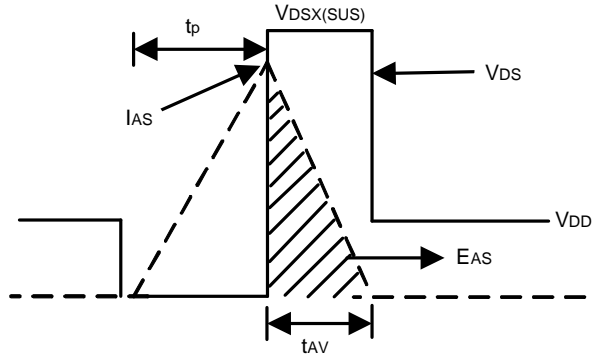
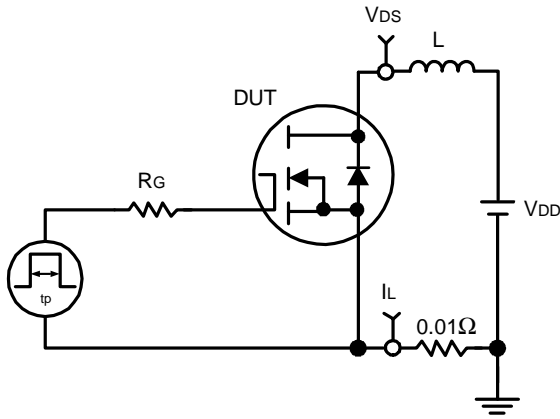
Capacitance



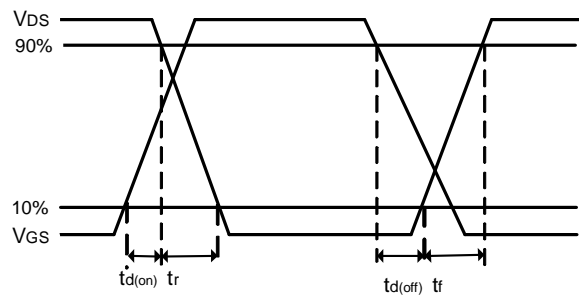
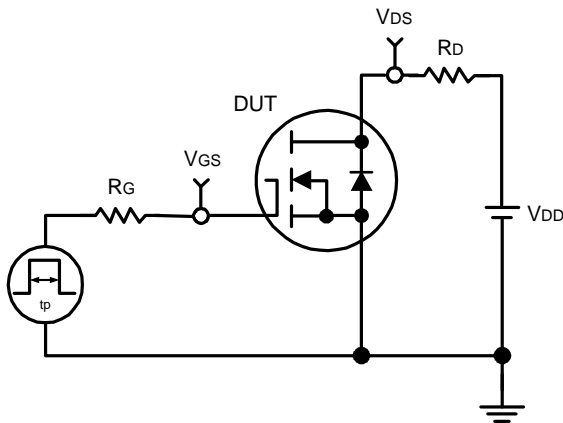
Gate Charge



Avalanche Test Circuit and Waveforms

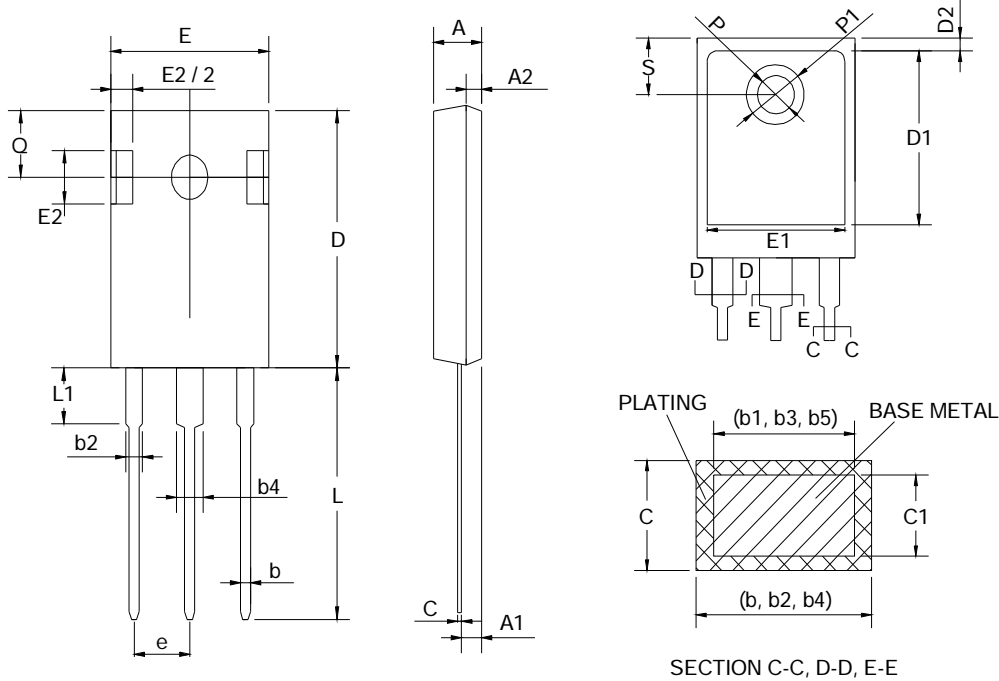


Switching Time Test Circuit and Waveforms



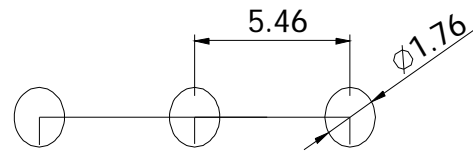
Package Information

TO-247



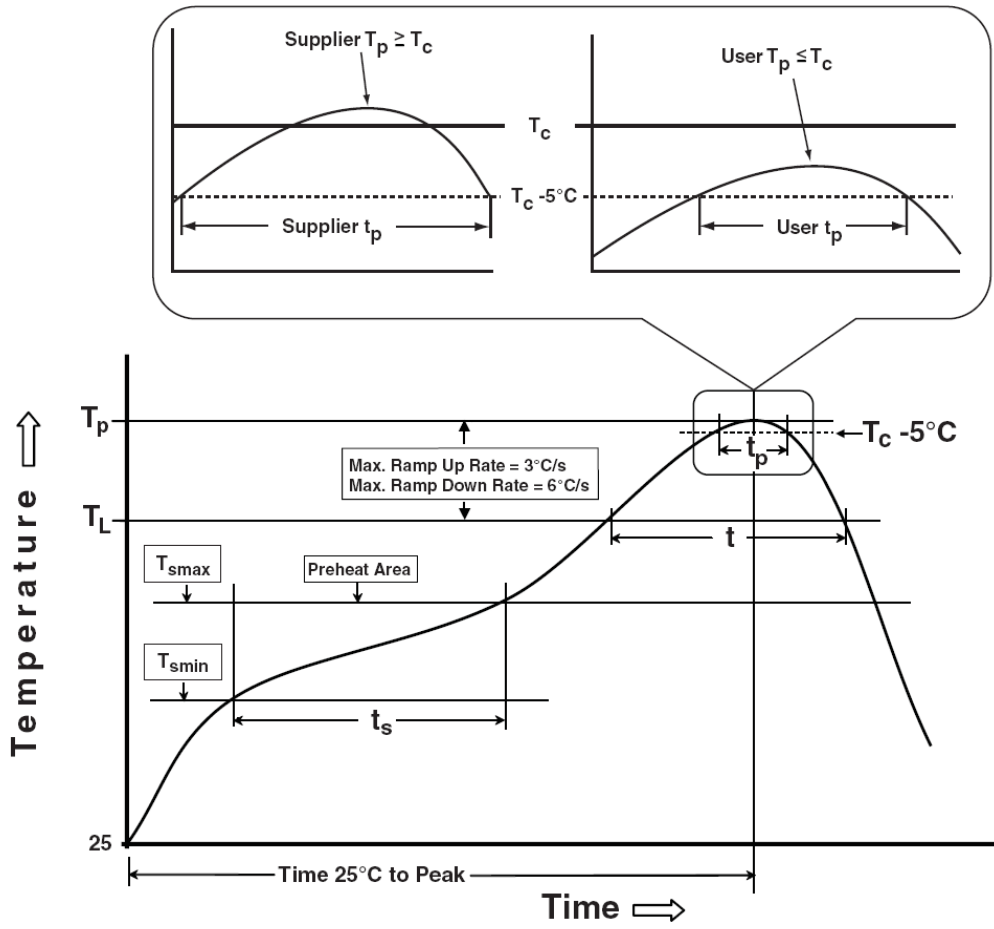
DIMENSIONS	TO-247			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.7	5.31	0.185	0.209
A1	2.21	2.59	0.087	0.102
A2	1.5	2.49	0.059	0.098
D	20.8	21.46	0.819	0.845
E	15.49	16.26	0.610	0.640
E2	4.32	5.49	0.170	0.216
e	5.46 BSC		0.215 BSC	
L	19.81	20.32	0.780	0.800
L1	-	4.5	-	0.177
P	3.56	3.66	0.140	0.144
Q	5.38	6.2	0.212	0.244
S	6.15 BSC		0.242 BSC	
b	0.99	1.4	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.65	2.39	0.065	0.094
b3	1.65	2.34	0.065	0.092
b4	2.59	3.43	0.102	0.135
b5	2.59	3.38	0.102	0.133
c	0.38	0.89	0.015	0.035
c1	0.38	0.84	0.015	0.033
D1	13.08	-	0.515	-
D2	0.51	1.35	0.020	0.053
E1	13.46	-	0.530	-
P1	-	7.4	-	0.291

RECOMMENDED LAND PATTERN



UNIT: mm

Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak		
Temperature min (T_{smin})	100 °C	150 °C
Temperature max (T_{smax})	150 °C	200 °C
Time (T_{smin} to T_{smax}) (t_s)	60-120 seconds	60-120 seconds
Average ramp-up rate (T_{smax} to T_p)	3 °C/second max.	3°C/second max.
Liquidous temperature (T_L)	183 °C	217 °C
Time at liquidous (t_L)	60-150 seconds	60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_p)** within 5°C of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.		

Table 1. SnPb Eutectic Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HOLT	JESD-22, A108	1000 Hrs, Bias @ 125°C
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

Customer Service

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